

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	"Crystallization of amorphous Zr-Ni alloys in the presence of H ₂ , CO, O ₂ , N ₂ and argon gases", Aoki et al., Journal of Materials Science, Vol. 21 pages 793-798, 1986(Aoki)
V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
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